## Notice of References Cited Application/Control No. 10/617,617 Examiner Karen E. Toth Applicant(s)/Patent Under Reexamination KAASTRUP ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0006634	01-2002	Han et al.	435/25
*	В	US-2003/0139366	07-2003	Roberts et al.	514/44
*	С	US-5,964,993	10-1999	Blubaugh et al.	204/403.09
*	D	US-2004/0072218	04-2004	Quan Pan, Shen	435/006
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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